

<b>Notice of References Cited</b>	Application/Control No. 09/830,030	Applicant(s)/Patent Under Reexamination ICHIKAWA ET AL.	
	Examiner Hien Tran	Art Unit 1764	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,459,119	10-1995	Abe et al.	502/326
	B	US-6,274,099	08-2001	Maus et al.	422/180
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2,071,640	09-1981	GB	---	--
	O	WO 96/12876	05-1996	WO	Maus et al	--
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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